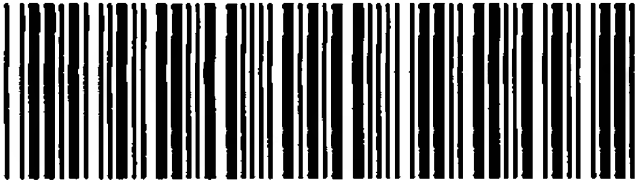


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/646,709	OHNISHI, SADAYUKI	
	Examiner	Art Unit	
	Phat X. Cao	2814	

SEARCHED			
Class	Subclass	Date	Examiner
257	759	6/29/2007	PC
257	762,758	6/29/2007	PC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST: IS&R and BRS	6/29/2007	PC